


<b>Search Notes</b>  	<b>Application/Control No.</b>  10537407	<b>Applicant(s)/Patent Under Reexamination</b>  IMAGAWA ET AL.
	<b>Examiner</b>  David K O'Dell	<b>Art Unit</b>  1625

SEARCHED			
Class	Subclass	Date	Examiner
514	316		

SEARCH NOTES		
Search Notes	Date	Examiner
STN (attached), EAST, PALM	8/23/2008	dko

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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